

Search Notes

Application/Control No.

10/507,066

Examiner

Benny Lee

Applicant(s)/Patent under
Reexamination

YE, SHEN

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
333	99S,204, 219	10/18/2006	BTL
505	210,866	10/18/2006	BTL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR